

# Search Notes



Application/Control No.

10/662,418

Examiner

Tae H. Yoon

Applicant(s)/Patent under  
Reexamination

CHISHOLM ET AL.

Art Unit

1714

## SEARCHED

Class	Subclass	Date	Examiner
S26	222	9-2-05	ny
	321		
	329.7		
ATD		1-19-06	ny
ATD		7-18-06	ny
ATD		11-10-06	ny

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	9-1-05	ny
Inventor Search	9-2-05	ny